

**PowerMOS transistor
Fast Recovery Diode FET**

**BUK637-400A
BUK637-400B**

T-39-15

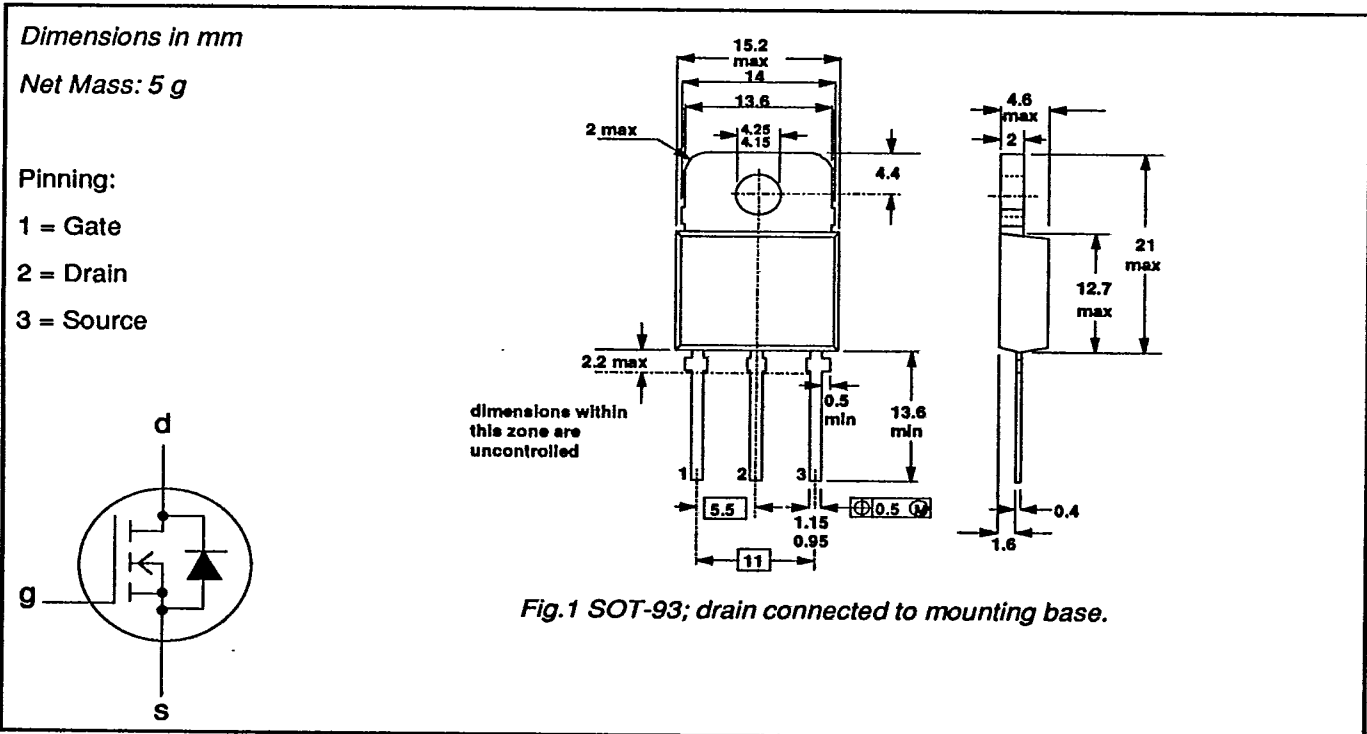
GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a plastic envelope. FREDFET with fast recovery reverse diode, particularly suitable for motor control applications, eg. in full bridge configurations for which faster recovery characteristics simplify design for inductive loads.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | MAX. | MAX. | UNIT |
|--------------|----------------------------------|--------------|--------------|----------|
| | BUK637 | -400A | -400B | |
| V_{DS} | Drain-source voltage | 400 | 400 | V |
| I_D | Drain current (DC) | 14 | 12 | A |
| P_{tot} | Total power dissipation | 180 | 180 | W |
| $R_{DS(ON)}$ | Drain-source on-state resistance | 0.5 | 0.6 | Ω |
| t_{rr} | Diode reverse recovery time | 250 | 250 | ns |

MECHANICAL DATA



- Notes**
1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
 2. Accessories supplied on request: refer to Mounting instructions for SOT93 envelope.

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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--------------|----------------------------------|---------------------------------------|------|-------------|------------------|
| V_{DS} | Drain-source voltage | - | - | 400 | V |
| V_{DGR} | Drain-gate voltage | $R_{GS} = 20 \text{ k}\Omega$ | - | 400 | V |
| $\pm V_{GS}$ | Gate-source voltage | - | - | 30 | V |
| I_D | Drain current (DC) | $T_{mb} = 25 \text{ }^\circ\text{C}$ | - | -400A 14 | A |
| I_D | Drain current (DC) | $T_{mb} = 100 \text{ }^\circ\text{C}$ | - | -400B 12 | A |
| I_{DM} | Drain current (pulse peak value) | $T_{mb} = 25 \text{ }^\circ\text{C}$ | - | 8.8 7.6 | A |
| I_{DM} | Drain current (pulse peak value) | $T_{mb} = 25 \text{ }^\circ\text{C}$ | - | 56 48 | A |
| P_{tot} | Total power dissipation | $T_{mb} = 25 \text{ }^\circ\text{C}$ | - | 180 | W |
| T_{stg} | Storage temperature | - | -55 | 150 | $^\circ\text{C}$ |
| T_j | Junction Temperature | - | - | 150 | $^\circ\text{C}$ |

THERMAL RESISTANCES

| | |
|--------------------------------|-----------------------------------|
| From junction to mounting base | $R_{th\ j-mb} = 0.69 \text{ K/W}$ |
| From junction to ambient | $R_{th\ j-a} = 45 \text{ K/W}$ |

STATIC CHARACTERISTICS
 $T_{mb} = 25 \text{ }^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|----------------------------------|----------------------------------------------------------------------------------|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$ | 400 | - | - | V |
| $V_{GS(TO)}$ | Gate threshold voltage | $V_{DS} = V_{GS}; I_D = 1 \text{ mA}$ | 2.1 | 3.0 | 4.0 | V |
| I_{DSS} | Zero gate voltage drain current | $V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ | - | 2 | 20 | μA |
| I_{DSS} | Zero gate voltage drain current | $V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ }^\circ\text{C}$ | - | 0.1 | 1.0 | mA |
| I_{GSS} | Gate source leakage current | $V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$ | - | 10 | 100 | nA |
| $R_{DS(ON)}$ | Drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 6.5 \text{ A}$ | - | 0.4 | 0.5 | Ω |
| | | BUK637-400A | - | 0.5 | 0.6 | Ω |
| | | BUK637-400B | - | 0.5 | 0.6 | Ω |

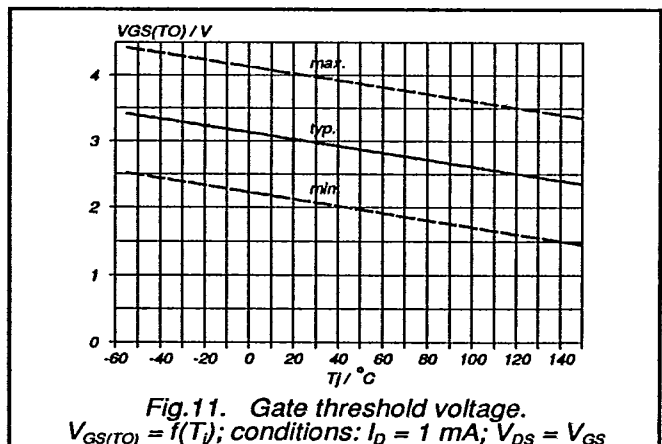
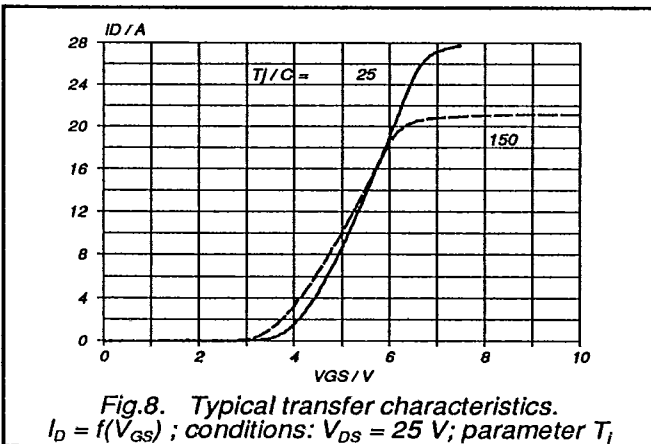
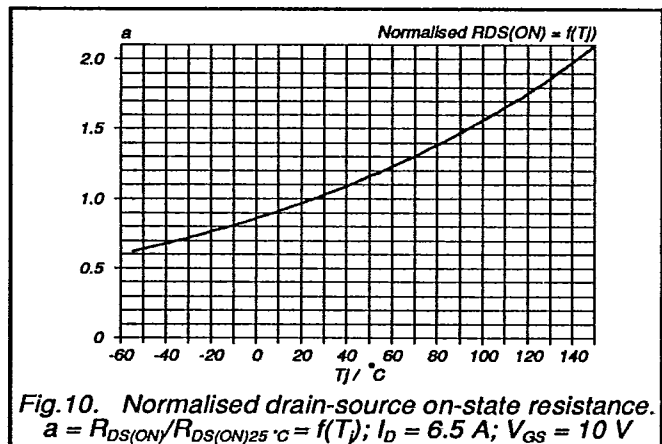
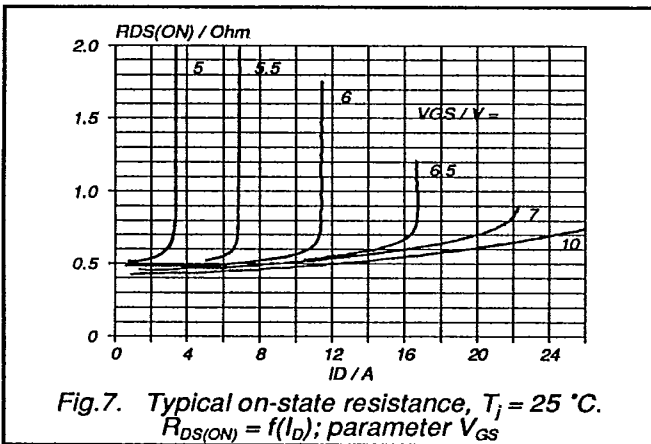
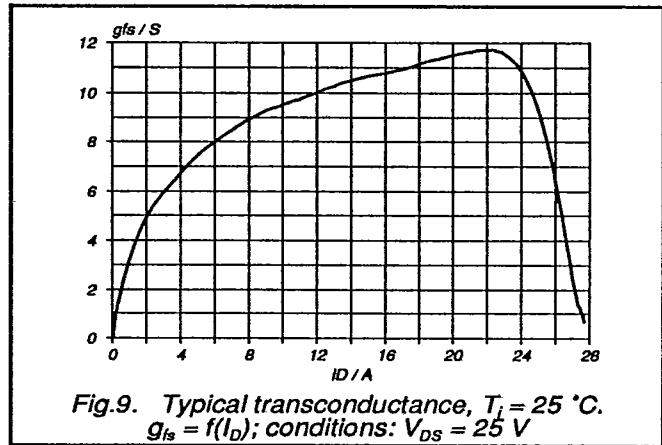
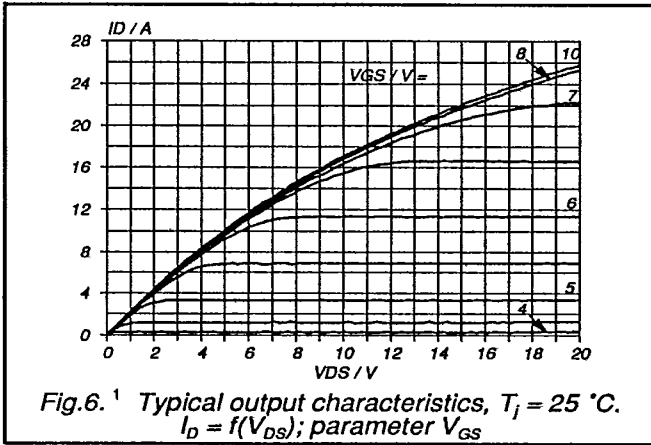
DYNAMIC CHARACTERISTICS
 $T_{mb} = 25 \text{ }^\circ\text{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|----------------------------|------------------------------------------------------------------|------|------|------|------|
| g_{fs} | Forward transconductance | $V_{DS} = 25 \text{ V}; I_D = 6.5 \text{ A}$ | 5.0 | 8.0 | - | S |
| C_{iss} | Input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ | - | 1500 | 1800 | pF |
| C_{oss} | Output capacitance | | - | 170 | 270 | pF |
| C_{rss} | Feedback capacitance | | - | 70 | 120 | pF |
| $t_{d\ on}$ | Turn-on delay time | $V_{DD} = 30 \text{ V}; I_D = 2.8 \text{ A};$ | - | 20 | 40 | ns |
| t_r | Turn-on rise time | $V_{GS} = 10 \text{ V}; R_{GS} = 50 \text{ } \Omega;$ | - | 60 | 90 | ns |
| $t_{d\ off}$ | Turn-off delay time | $R_{gen} = 50 \text{ } \Omega$ | - | 200 | 250 | ns |
| t_f | Turn-off fall time | | - | 75 | 90 | ns |
| L_d | Internal drain inductance | Measured from contact screw on tab to centre of die | - | 5 | - | nH |
| L_d | Internal drain inductance | Measured from drain lead 6 mm from package to centre of die | - | 5 | - | nH |
| L_s | Internal source inductance | Measured from source lead 6 mm from package to source bond pad | - | 12.5 | - | nH |

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